

MOS FIELD EFFECT TRANSISTOR 2SJ557

P-CHANNEL MOS FIELD EFFECT TRANSISTOR FOR SWITCHING

DESCRIPTION

The 2SJ557 is a switching device which can be driven directly by a 4 V power source.

The 2SJ557 features a low on-state resistance and excellent switching characteristics, and is suitable for applications such as power switch of portable machine and so on.

FEATURES

- Can be driven by a 4 V power source
- Low on-state resistance

 $\begin{array}{l} {\sf R}_{DS(on)1} = 155 \mbox{ m}\Omega \mbox{ MAX.} \ ({\sf V}_{GS} = -10 \mbox{ V}, \mbox{ I}_{D} = -1.0 \mbox{ A}) \\ {\sf R}_{DS(on)2} = 255 \mbox{ m}\Omega \mbox{ MAX.} \ ({\sf V}_{GS} = -4.5 \mbox{ V}, \mbox{ I}_{D} = -1.0 \mbox{ A}) \\ {\sf R}_{DS(on)3} = 290 \mbox{ m}\Omega \mbox{ MAX.} \ ({\sf V}_{GS} = -4.0 \mbox{ V}, \mbox{ I}_{D} = -1.0 \mbox{ A}) \end{array}$

ORDERING INFORMATION

PART NUMBER	PACKAGE
2SJ557	SC-96 (Mini Mold Thin Type)

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

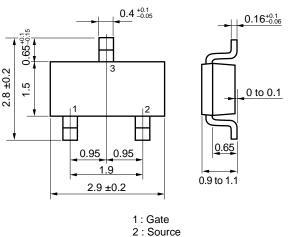
Drain to Source Voltage	VDSS	-30	V
Gate to Source Voltage	Vgss	-20 / +5	V
Drain Current (DC)	ID(DC)	±2.5	А
Drain Current (pulse) ^{Note1}	D(pulse)	±10	А
Total Power Dissipation	PT1	0.2	W
Total Power Dissipation Note2	Рт2	1.25	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	–55 to +150	°C

Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1 %

- **2.** Mounted on FR-4 Board, $t \le 5$ sec.
- **Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

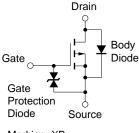
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PACKAGE DRAWING (Unit : mm)



2 : Source 3 : Drain

EQUIVALENT CIRCUIT



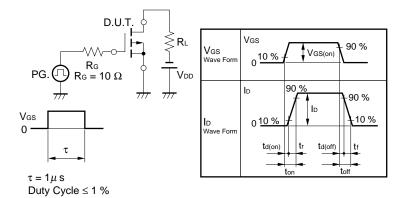
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Document No. Date Published Printed in Japan

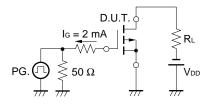
ELECTRICAL CHARACTERISTICS (TA = 25°C)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain Cut-off Current	IDSS	$V_{DS} = -30 V, V_{GS} = 0 V$			-10	μA
Gate Leakage Current	lgss	$V_{GS} = \pm 16 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			±10	μA
Gate Cut-off Voltage	VGS(off)	$V_{DS} = -10 V$, $I_{D} = -1 mA$	-1.0	-1.7	-2.5	V
Forward Transfer Admittance	y _{fs}	$V_{DS} = -10 V$, $I_D = -1.5 A$	1	2.5		S
Drain to Source On-state Resistance	RDS(on)1	$V_{GS} = -10 \text{ V}, \text{ ID} = -1.0 \text{ A}$		114	155	mΩ
	RDS(on)2	$V_{GS} = -4.5 \text{ V}, \text{ Id} = -1.0 \text{ A}$		178	255	mΩ
	RDS(on)3	$V_{GS} = -4.0 \text{ V}, \text{ ID} = -1.0 \text{ A}$		212	290	mΩ
Input Capacitance	Ciss	V _{DS} = -10 V		312		pF
Output Capacitance	Coss	V _{GS} = 0 V		117		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		56		pF
Turn-on Delay Time	td(on)	$V_{DD} = -10 V$		12		ns
Rise Time	tr	ID = -1.0 A		7		ns
Turn-off Delay Time	td(off)	$V_{GS(on)} = -10 V$		133		ns
Fall Time	tr	R _G = 10 Ω		85		ns
Total Gate Charge	Q _G	V _{DD} = -10 V		2.8		nC
Gate to Source Charge	Q _{GS}	ID = -2.5 A		1.0		nC
Gate to Drain Charge	Qgd	$V_{GS} = -4.0 V$		1.2		nC
Diode Forward Voltage	VF(S-D)	IF = 2.5 A, VGS = 0 V		0.84		V
Reverse Recovery Time	trr	IF = 2.5 A, VGs = 0 V		28		ns
Reverse Recovery Charge	Qrr	di/dt = 50 A / μ s		7.8		nC

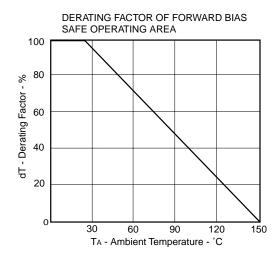
TEST CIRCUIT 1 SWITCHING TIME

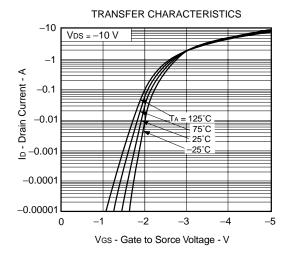


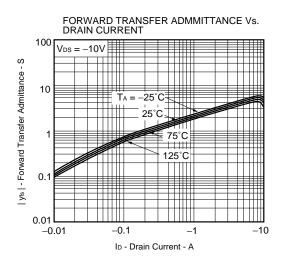
TEST CIRCUIT 2 GATE CHARGE

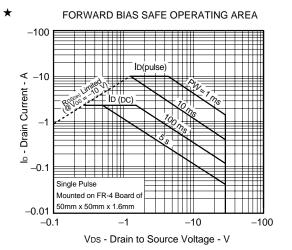


TYPICAL CHARACTERISTICS (TA = 25°C)

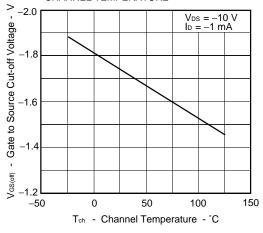




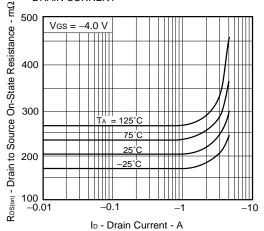


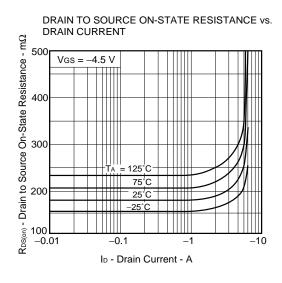


GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE

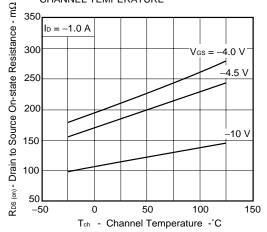


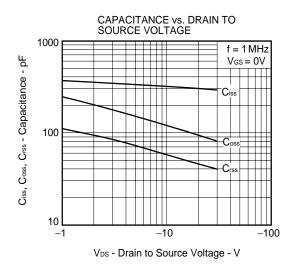
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

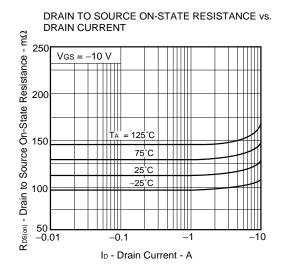




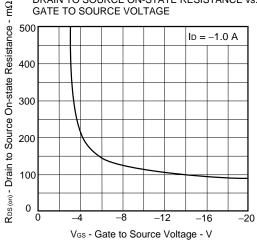




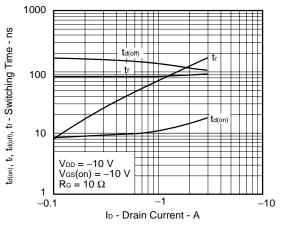




DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

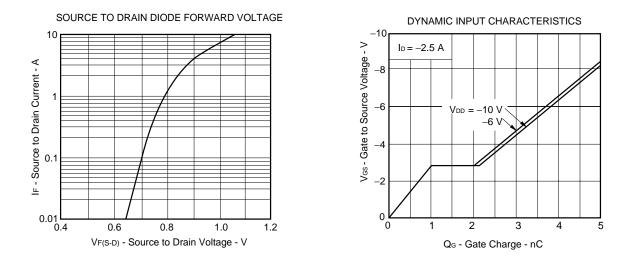




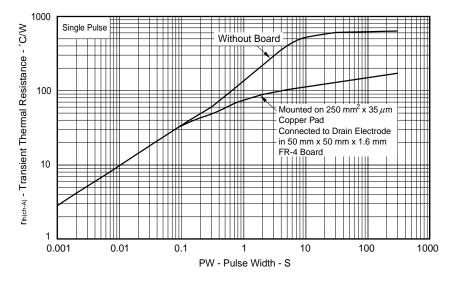




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TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



[MEMO]

[MEMO]

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